

# **IEC 61649 Ed. 1.0 B:1997, Goodness-of-fit Tests, Confidence Intervals And Lower Confidence Limits For Weibull Distributed Data By IEC TC/SC 56**

**By IEC TC/SC 56**

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calculates confidence intervals based on the results. Chemical Engineering Education [ TABLE 1. (1.0 ppm), minimal loss of

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7.8.1 Goodness of fit 113. In lognormally distributed data, the procedure is as in the 1-sided test, except all tests are at the 0.025 significance level to

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in the 2025 Baseline 3 A-56 Table 4-1. counties are projected to be below 65 but exceed 60 ppb (0 200 400 I i confidence intervals)

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